

TSG30N120B

IGBT

DRAWING

Features

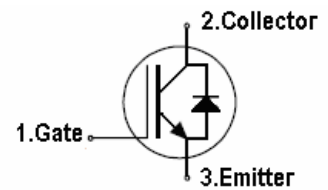
- 1200V,30A
- $V_{CE(sat)(typ.)}=2.1V@V_{GE}=15V$
- High speed switching
- Higher system efficiency
- Soft current turn-off waveforms
- Square RBSOA



G C E

General Description

TS NPT IGBTs offer lower losses and higher energy efficiency for application such as IH (induction heating), UPS, general inverter and other soft switching applications.



Absolute Maximum Ratings

| Symbol | Parameter | Spec | Units |
|-----------|--|-------------|------------------|
| V_{CES} | Collector-Emitter Voltage | 1200 | V |
| V_{GES} | Gate-Emitter Voltage | ± 30 | V |
| I_C | Continuous Collector Current ($T_C=25\text{ }^\circ\text{C}$) | 55 | A |
| | Continuous Collector Current ($T_C=100\text{ }^\circ\text{C}$) | 28 | A |
| I_{CM} | Pulsed Collector Current (Note 1) | 240 | A |
| I_F | Diode Continuous Forward Current ($T_C=100\text{ }^\circ\text{C}$) | 25 | A |
| I_{FM} | Diode Maximum Forward Current (Note 1) | 240 | A |
| tsc | Short Circuit Withstand Time | 10 | us |
| P_D | Maximum Power Dissipation ($T_C=25\text{ }^\circ\text{C}$) | 300 | W |
| | Maximum Power Dissipation ($T_C=100\text{ }^\circ\text{C}$) | 120 | W |
| T_J | Operating Junction Temperature Range | -55 to +150 | $^\circ\text{C}$ |
| T_{STG} | Storage Temperature Range | -55 to +150 | $^\circ\text{C}$ |

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature

Thermal Characteristics

| Symbol | Parameter | Spec | Units |
|---------|--|------|---------------------------|
| Rth j-c | Thermal Resistance, Junction to case for IGBT | 0.42 | $^\circ\text{C}/\text{W}$ |
| Rth j-c | Thermal Resistance, Junction to case for Diode | 0.83 | $^\circ\text{C}/\text{W}$ |
| Rth j-a | Thermal Resistance, Junction to Ambient | 40 | $^\circ\text{C}/\text{W}$ |

Electrical Characteristics (TC=25℃ unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|---------------|--------------------------------------|---|------|-----|------|----------|
| BV_{CES} | Collector-Emitter Breakdown Voltage | $V_{GE}=0V, I_C=250\mu A$ | 1200 | | | V |
| I_{CES} | Collector-Emitter Leakage Current | $V_{CE}=1200V, V_{GE}=0V$ | | | 250 | μA |
| I_{GES} | Gate Leakage Current, Forward | $V_{GE}=30V, V_{CE}=0V$ | | | 100 | nA |
| | Gate Leakage Current, Reverse | $V_{GE}=-30V, V_{CE}=0V$ | | | -100 | nA |
| $V_{GE(th)}$ | Gate Threshold Voltage | $V_{GE}=V_{CE}, I_C=250\mu A$ | 4 | 5 | 6 | V |
| $V_{CE(sat)}$ | Collector-Emitter Saturation Voltage | $V_{GE}=15V, I_C=30A$ | | 2.1 | 2.3 | V |
| Q_g | Total Gate Charge | $V_{CC}=960V$ | | 178 | | nC |
| Q_{ge} | Gate-Emitter Charge | $V_{GE}=15V$ | | 36 | | nC |
| Q_{gc} | Gate-Collector Charge | $I_C=30A$ | | 84 | | nC |
| $t_{d(on)}$ | Turn-on Delay Time | $V_{CC}=600V$ $V_{GE}=0V/15V, I_C=30A$ $R_G=28\Omega$ Inductive Load TC=25℃ | | 54 | | ns |
| t_r | Turn-on Rise Time | | | 72 | | ns |
| $t_{d(off)}$ | Turn-off Delay Time | | | 671 | | ns |
| t_f | Turn-off Fall Time | | | 44 | | ns |
| E_{on} | Turn-on Switching Loss | | | 2.9 | | mJ |
| E_{off} | Turn-off Switching Loss | | | 2.2 | | mJ |
| E_{ts} | Total Switching Loss | | | 5.1 | | mJ |
| C_{ies} | Input Capacitance | $V_{CE}=30V$ | | 645 | | pF |
| C_{oes} | Output Capacitance | $V_{GE}=0V$ | | 206 | | pF |
| C_{res} | Reverse Transfer Capacitance | $f=100kHz$ | | 115 | | pF |
| R_{Gint} | Integrated gate resistor | | | 2.1 | | Ω |

Electrical Characteristics of Diode (TC=25℃ unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|----------|-------------------------------------|--|-----|-----|------|-------|
| V_F | Diode Forward Voltage | $I_F=30A$ | | 2.0 | 2.2 | V |
| t_{rr} | Diode Reverse Recovery Time | $V_{CE}=600V$ $I_F=30A$ $dI_F/dt=200A/\mu s$ | | 197 | | ns |
| I_{rr} | Diode peak Reverse Recovery Current | | | 20 | | A |
| Q_{rr} | Diode Reverse Recovery Charge | | | | 1923 | |

Typical Characteristics

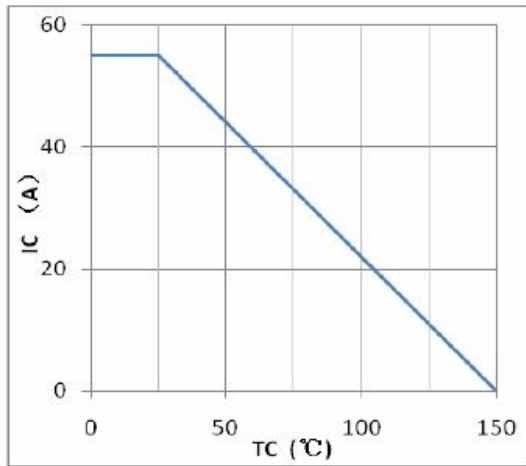


Figure1: maximum DC collector current VS. case temperature

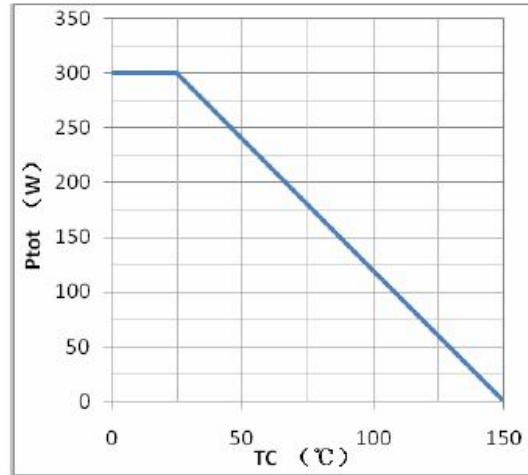


Figure2: power dissipation VS. case temperature

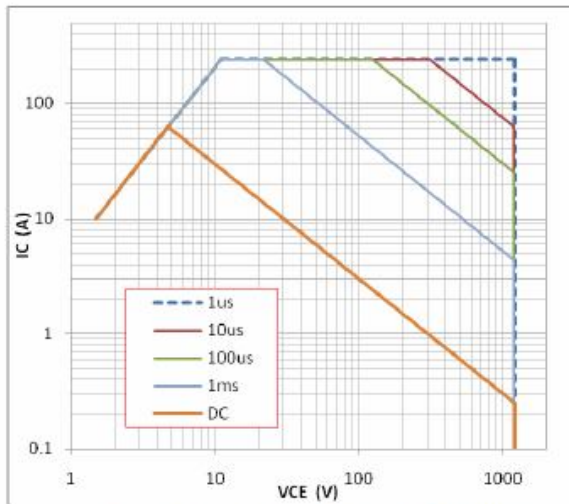


Figure3: forward SOA, TC=25°C, TJ≤150°C

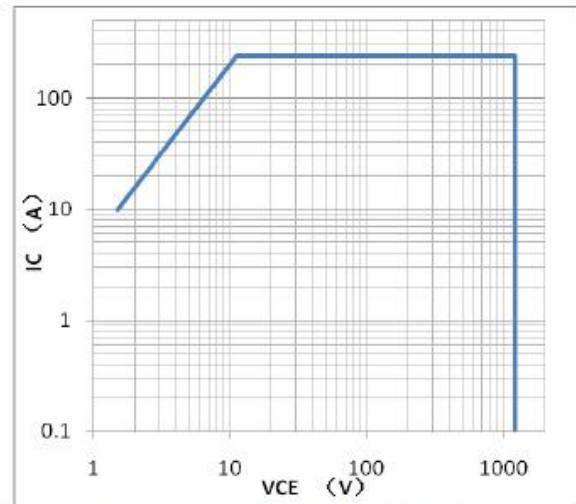


Figure4: reverse bias SOA, TJ=150°C, VGE=15V

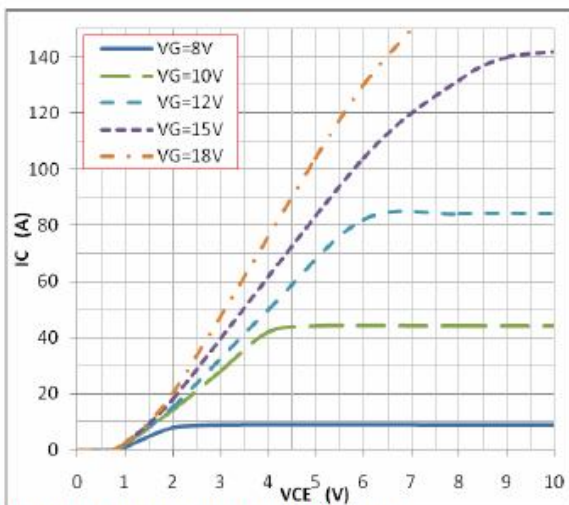


Figure5: typical IGBT output characteristics, TJ=25°C, tp=300us

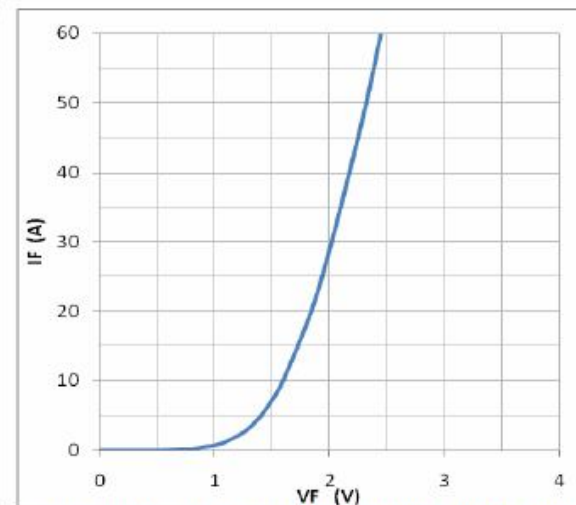


Figure6: typical trans characteristics, VCE=20V, tp=20us

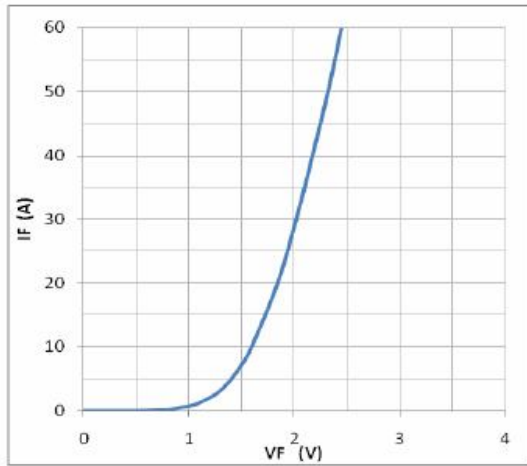


Figure7: typical diode forward characteristic, $t_p=300\mu s$

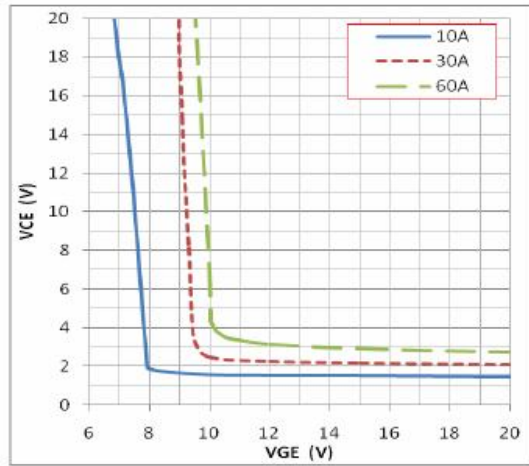


Figure8: typical VCE VS. VGE, $T_J=25^\circ C$

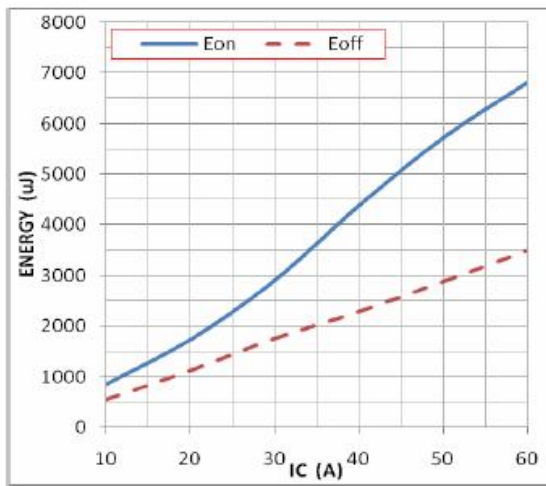


Figure 9: typical energy loss VS. I_C , $T_C=25^\circ C$, $L=500\mu H$, $V_{CE}=600V$, $V_{GE}=15V$, $R_g=28\Omega$

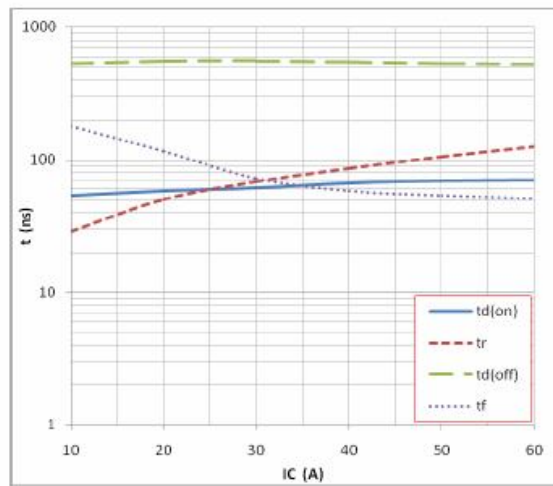


Figure10: typical switching time VS. I_C , $T_C=25^\circ C$, $L=500\mu H$, $V_{CE}=600V$, $V_{GE}=15V$, $R_g=28\Omega$

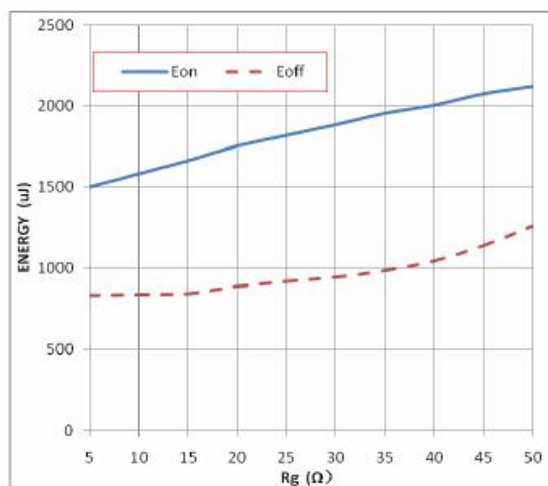


Figure11: typical energy loss VS. R_g , $T_C=25^\circ C$, $L=500\mu H$, $V_{CE}=600V$, $V_{GE}=15V$, $I_C=30A$

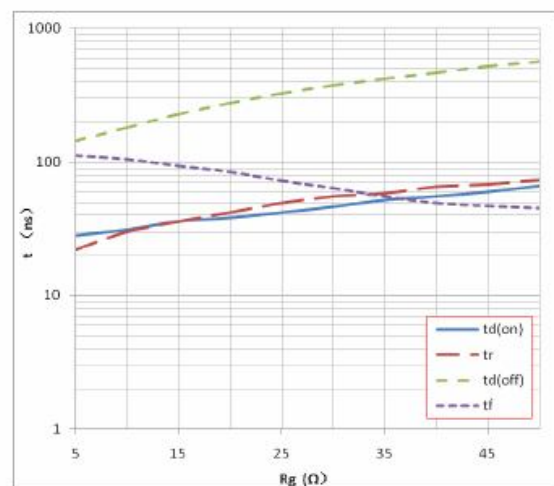


Figure12: typical switching time VS. R_g , $T_C=25^\circ C$, $L=500\mu H$, $V_{CE}=600V$, $V_{GE}=15V$, $I_C=30A$

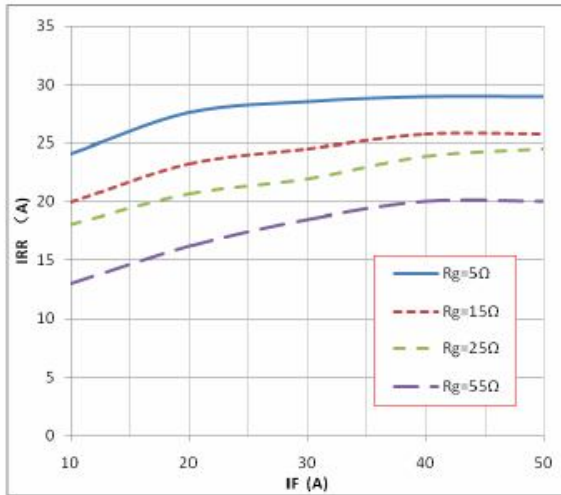


Figure13: typical diode IRR VS. IF, TC=25°C

VCC=600V,VGE=15V

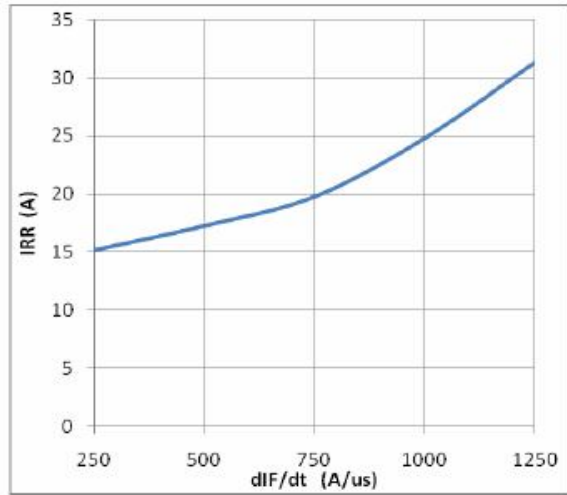


Figure14: typical diode IRR VS. dIF/dt

VCC=600V,VGE=15V,IF=30A

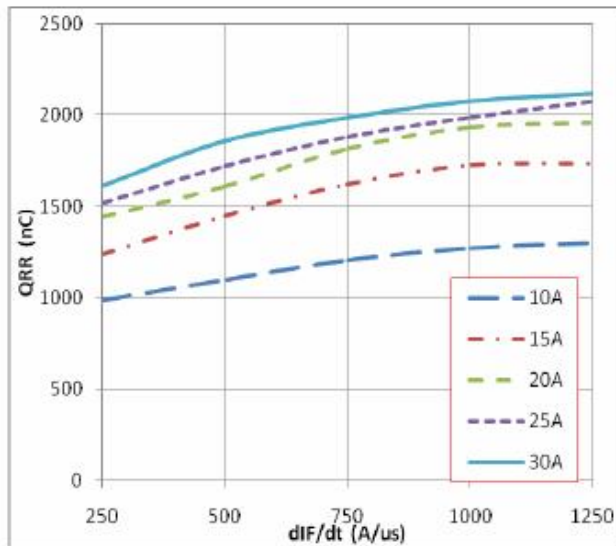


Figure15: typical diode QRR VS. dIF/dt, VCC=600V, VGE=15V

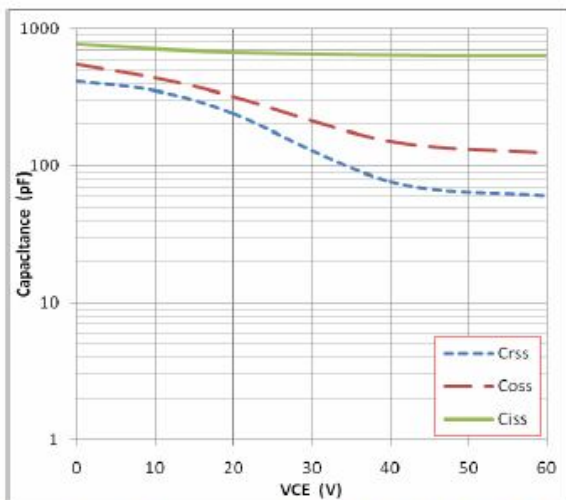


Figure16: typical capacitance VS. VCE, VGE=0V, f=100kHz

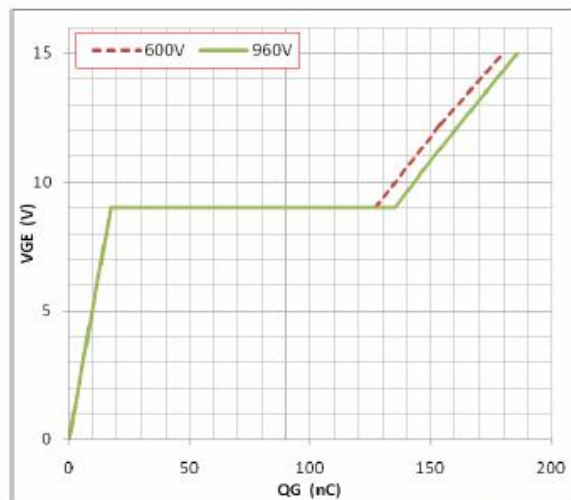


Figure17: typical gate charge VS. VGE, IC=30A

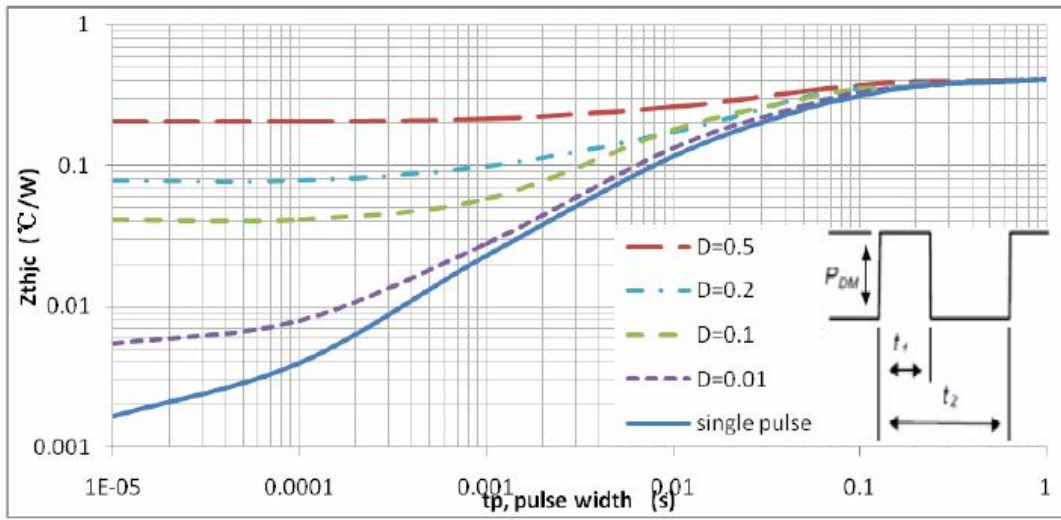


Figure18:normalized transient thermal impedance,junction-to-case
 Note1.Duty factor $D=t_1/t_2$; Note2:peak $T_J=P_{DM} \times Z_{thjc}+T_C$

Mechanical Dimensions

